

INTERNATIONAL STANDARD



**Printed electronics –
Part 203: Materials – Semiconductor ink**



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**Printed electronics –
Part 203: Materials – Semiconductor ink**

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

PRINTED ELECTRONICS –

Part 203: Materials – Semiconductor ink

FOREWORD

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International Standard IEC 62899-203 has been prepared by IEC technical committee 119: Printed Electronics.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
119/226/FDIS	119/234/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62899 series, published under the general title *Printed electronics*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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INTRODUCTION

The IEC 62899 series deals mainly with evaluation methods for materials of printed electronics. The series also includes storage methods, packaging and marking, and transportation conditions.

The IEC 62899 series is divided into several parts according to each material. Each part is prepared as a generic specification containing fundamental information for the area of printing electronics.

The IEC 62899 series consists of the following parts:

Part 1: Terminology

Part 201: Materials – Substrates

Part 202: Materials – Conductive ink

Part 203: Materials – Semiconductor ink

Part 250: Material technologies required in printed electronics for wearable smart devices

Part 301-X: Equipment – Contact printing – Rigid master

Part 302-X: Equipment – Inkjet

Part 303-X: Equipment – Roll-to-roll printing

Part 401: Printability – Overview

Part 402-X: Printability – Measurement of qualities

Part 403-X: Printability – Requirements for reproducibility

Part 502-X: Quality assessment – Organic light emitting diode (OLED) elements

Furthermore, sectional specifications, blank detail specifications, and detail specifications for each material will be based on these parts.

This part of IEC 62899 is prepared for semiconducting materials used in printed electronics and contains the test conditions, the evaluation methods and the storage conditions.

PRINTED ELECTRONICS –

Part 203: Materials – Semiconductor ink

1 Scope

This part of IEC 62899 defines terms and specifies standard methods for characterisation and evaluation.

This document is applicable to semiconductor inks and semiconductive layers that are made from semiconductor inks.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 62860, *Test methods for the characterization of organic transistors and materials*

ISO 5-2, *Photography and graphic technology – Density measurements – Part 2: Geometric conditions for transmittance density*

ISO 5-3, *Photography and graphic technology – Density measurements – Part 3: Spectral conditions*

ISO 124, *Latex, rubber – Determination of total solids content*

ISO 291, *Plastics – Standard atmospheres for conditioning and testing*

ISO 304, *Surface active agents – Determination of surface tension by drawing up liquid films*

ISO 489:1999, *Plastics – Determination of refractive index*

ISO 758, *Liquid chemical products for industrial use – Determination of density at 20°C*

ISO 1183-1, *Plastics – Methods for determining the density of non-cellular plastics – Part 1: Immersion method, liquid pycnometer method and titration method*

ISO 1555, *Plastics – Resins in the liquid state or as emulsions or dispersions – Determination of apparent viscosity by the Brookfield Test method*

ISO 2592, *Petroleum and related products – Determination of flash and fire points – Cleveland closed cup method*

ISO 2719, *Determination of flash point – Pensky-Martens closed cup method*

ISO 2811-1, *Paints and varnishes – Determination of density – Part 1: Pycnometer method*